

<b>Notice of References Cited</b>		Application/Control No. 10/573,459	Applicant(s)/Patent Under Reexamination JAMES, JASON L.	
		Examiner Hae M. Hyeon	Art Unit 2839	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,234,830 B1	05-2001	Ensz et al.	439/491
*	B	US-6,285,293 B1	09-2001	German et al.	340/687
*	C	US-6,330,307 B1	12-2001	Bloch et al.	379/25
*	D	US-6,350,148 B1	02-2002	Bartolutti et al.	439/489
*	E	US-6,499,861 B1	12-2002	German et al.	362/253
*	F	US-6,688,910 B1	02-2004	Macauley, Daniel Warren	439/491
*	G	US-6,750,643 B2	06-2004	Hwang et al.	324/66
*	H	US-6,900,629 B2	05-2005	Hwang et al.	324/158.1
*	I	US-2006/0094291 A1	05-2006	Caveney et al.	439/540.1
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.